Understanding Variation that Extends Statistical Process Control

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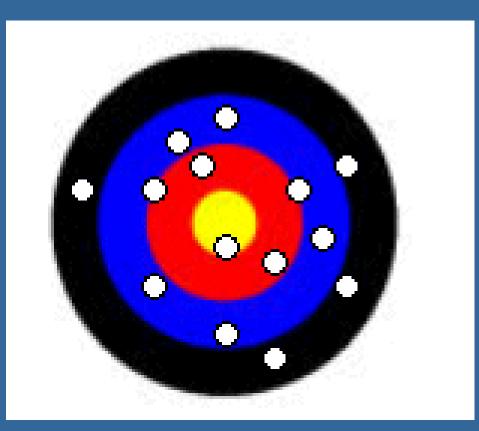
Organizational Background and Process ROI

Project Idea and Proposal Preposition Development

- If an average developer day cost is ~7000
- The total Program effort was 10220 day (100%)
- The testing phase was 1480 day (14.5%)
- Defect that are the result of documentation are 69% of all defects
- If we will assume the to correct 69% of all defects will take around 40% of the testing duration;
 means that:
 - that will be 740 day
 - With the overall cost of 518000
- However to add 100 review days in the static tests and another 20 of code inspection will end with the cost of 2100000
- And still we have saved at least 3080000 (440 days)
- Means that we ware able to reduce 4.5% of the project time

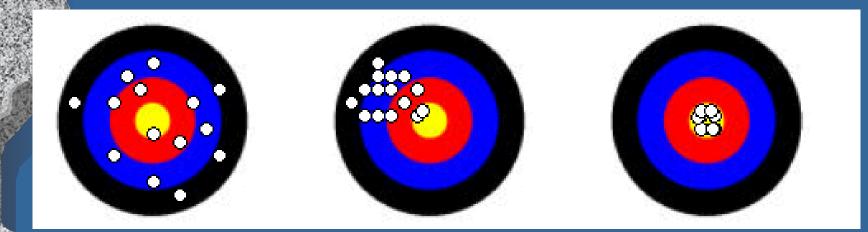
Our Business Process

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Our Improvement Target

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Covered Topics

Process Map
Statistical Process Control
Basic Metrics
Selection Tree for Control Charts and Visualizing the Data

- Control Charts Calculating and parameters
- Understanding Variation
- Case study first phase
- Reducing Variation
- Case study Second phase

Process Maps

The purpose of process maps is to:

Identify the complexity of the process

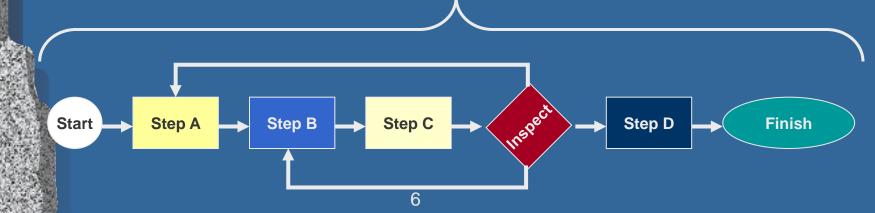
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• Communicate the focus of problem solving

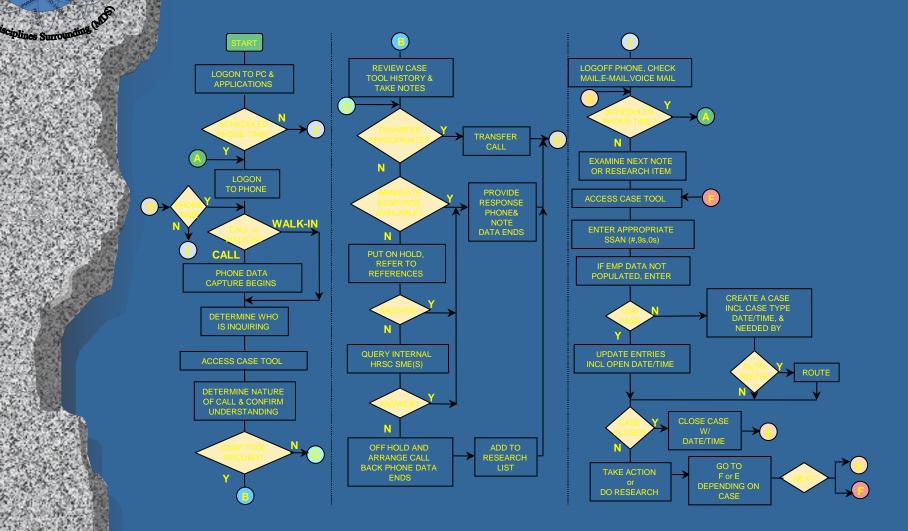
Process maps are *living* documents and must be changed as the process is changed

- They represent what is currently happening, not what you think is happening.
- They should be created by the people who are closest to the process

Process Map



Support Center. Process Map Example

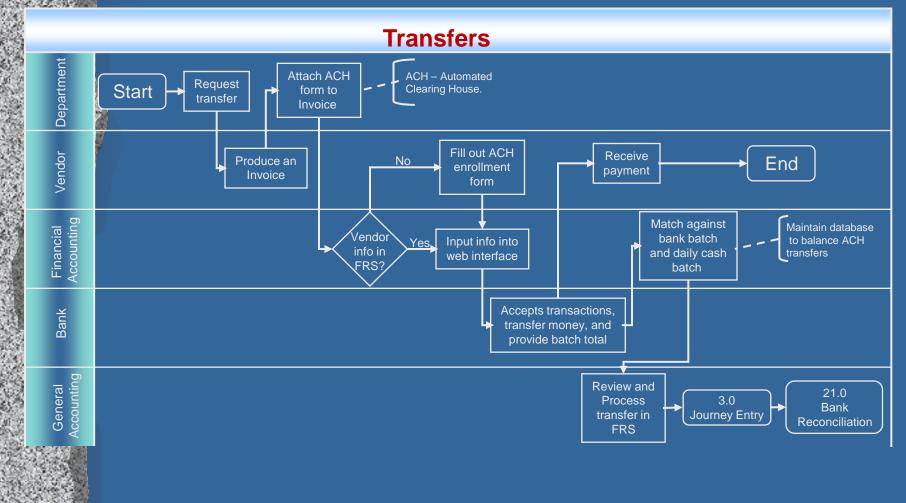


Cross Functional Process Map

inultiple departments or functional groups are involved in a complex process it museful to use cross functional process maps

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Draw in either vertical or horizontal swim lanes and label the functional groups and draw the process map



STATISTICAL PROCESS CONTROL

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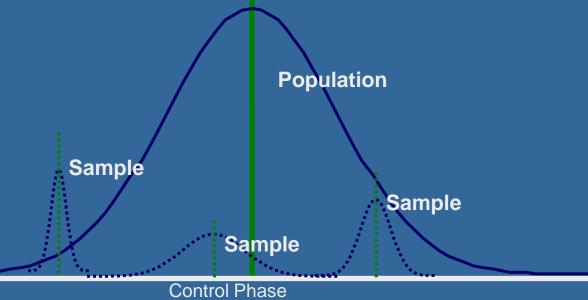
SPC Overview: Collecting Data

Population:

 An entire group of objects that have been made or will be made containing a characteristic of interest
 Sample:

- A sample is a subset of the population of interest
- The group of objects actually measured in a statistical study

 Samples are used to estimate the true population parameters



Purpose of Statistical Process Control

Every process has Causes of Variation known as:

- Common Cause: Natural variability
- Special Cause: Unnatural variability
 - Assignable: Reason for detected Variability
 - Pattern Change: Presence of trend or unusual pattern

SPC is a basic tool to monitor and improve variation in a process.

SPC is used to detect special cause variation telling us the process is "out of control" but does NOT tell us why.

SPC gives a glimpse of ongoing process capability AND is a visual management tool.

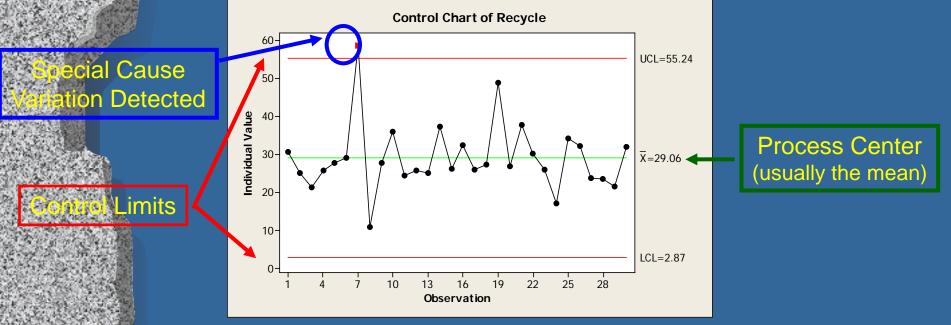
Elements of Control Charts

veloped by Dr Walter A. Shewhart of Bell Laboratories from 1924 aphical and visual plot of changes in the data over time

• This is necessary for visual management of your process.

Control charts were designed as a methodology for indicating change in performance, either variation or mean/median.

Charts have a central line and control limits to detect special cause variation.



Understanding the Power of SPC

ntrol charts indicate when a process is "out of control" or exhibiting **a set of the set**

C charts incorporate upper and lower control limits.
 The limits are typically +/- 3 σ from the centerline.
 These limits represent 99.73% of natural variability for normal distributions.

Control limits describe the process variability and are unrelated to customer specifications. (Voice of the Process instead of Voice of the Customer)

 An undesirable situation is having control limits wider than customer specification limits. This will exist for poorly performing processes with a Cp less than 1.0

Many SPC charts exist and selection must be appropriate for effectiveness.

General Steps for Constructing Control Charts

Select characteristic (critical "X" or CTQ) to be charted. Determine the purpose of the chart. Select data-collection points. Establish the basis for sub-grouping (only for Y's). Select the type of control chart. Determine the measurement method/criteria. Establish the sampling interval/frequency. Determine the sample size.

- Establish the basis of calculating the control limits.
- Set up the forms or software for charting data.
- Set up the forms or software for collecting data.
 - Prepare written instructions for all phases.
- Conduct the necessary training.





To get results, should we focus our behavior on the Y or X? X1...XN Dependent Independent Output Input Effect Cause Symptom Problem Monitor

If we find the "vital few" X's, first consider using SPC on the X's to achieve a desired Y?

Control

BASIC METRICS

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In any process improvement endeavor, The ultimate objective is to make the process:

Better: *DPU, DPMO, RTY* (*there are others, but they derive from these basic three*) **Faster:** *Cycle Time* **Cheaper:** *COPQ*

If you make the process better by *eliminating* defects you will make it faster If you choose to make the process faster, you will have to eliminate defects to be as fast as you can be If you make the process better or faster, you will necessarily make it cheaper

Cycle Time Defined

Think of Cycle Time in terms of your product or transaction in the eyes of the customer of the process:

- It is the time required for the product or transaction to go through the entire process, from beginning to end
- It is not simply the "touch time" of the value-added portion of the process

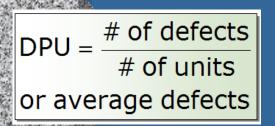
What is the cycle time of the process you mapped?

Is there any variation in the cycle time? Why?

Defects Per Unit (DPU)

Six Sigma methods quantify individual defects and not just defectives

- Defects account for all errors on a unit
 - A unit may have multiple defects
 - An incorrect invoice may have the wrong amount due *and* the wrong due date
- Defectives simply classifies the unit bad
 - Doesn't matter how many defects there are
 - The invoice is wrong, causes are unknown
- A unit:
 - Is the measure of volume of output from your area.
 - Is observable and countable. It has a discrete start and stop point.
 - It is an individual measurement and not an average of measurements. **Two Defects One Defective**









FTY is the traditional quality metric for yield

• Unfortunately, it does not account for any necessary rework

Total Units Passed

FTY = Total Units Tested

Units in = 50 Units Out = 50 Process A (Grips)

Units Out = 50 Process B (Shafts)

Units in = 50

Units in = 50 Units Out = 50

Process C (Club Heads)

Units Passed = 50 Units Tested = 50 Final Product (Set of Irons)



Defects Repaired

Defects Repaired 3







FTY = 100 %

Rolled Throughput Yield

RTY is a more appropriate metric for problemsolving $RTY = X_1 * X_2 * X_3$

- It accounts for losses due to rework steps
- Units in = 100 Units Out = 100 RTY = 0.6

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Units in = 100Units Out = 100RTY = 0.7

Units in = 100 Units Out = 100 RTY = 0.8

Units Passed = 100 Units Tested = 100

Process A (Grips)



Defects Repaired 4 Process B (Shafts)



3

Defects Repaired Defects



Process C (Club Heads)

Final Product (Set of Irons)



RTY = 33.6 %

RTY Estimate

In many organizations the long term data required to calculate RTY is not available, we can however estimate RTY using a known DPU as long as certain conditions are met. The Poisson distribution generally holds true for the random distribution of defects in a unit of product and is the basis for the estimation.

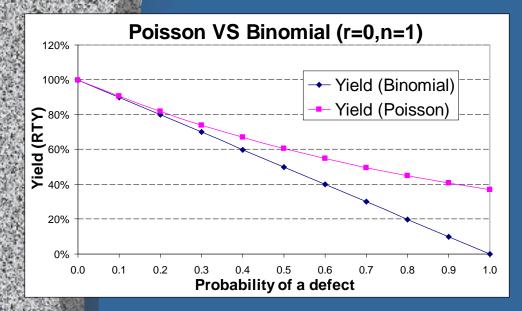
• The best estimate of the proportion of units containing no defects, or RTY is:

The mathematical constant **e** is the base of the natural logarithm. $e \approx 2.71828 \ 18284 \ 59045 \ 23536 \ 02874 \ 7135$

$$RTY = e^{-dpu}$$

Deriving RTY from DPU

The Binomial distribution is the true model for defect data, but the Poisson is the convenient model for defect data. The Poisson does a good job of predicting when the defect rates are low.



Probability of a defect	Yield (Binomial)	Yield (Poisson)	% Over Estimated
0.0	100%	100%	0%
0.1	90%	90%	0%
0.2	80%	82%	2%
0.3	70%	74%	4%
0.4	60%	67%	7%
0.5	50%	61%	11%
0.6	40%	55%	15%
0.7	30%	50%	20%
0.8	20%	45%	25%
0.9	10%	41%	31%
1.0	0%	37%	37%

Binomial

$$Y = \frac{n!}{r!(n-r)!}p^rq^{n-r}$$

n = number of units
r = number of predicted defects
p = probability of a defect occurrence
q = 1 - p

Now defect rates (p < 0.1), the Poisson approximates the Binomial fairly well.

Poisson

$$Y=\frac{(np)^r e^{-np}}{r!}$$

Deriving RTY from DPU - Modeling

Opportunity

or the unit shown above the following tata was gathered:

Unit

60 defects observed 60 units processed

at is the DPU?

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$$\mathsf{DPU} = \frac{\# \text{ of defects}}{\# \text{ of units}} = \frac{60}{60} = 1.0$$

What is probability that any given opportunity will be a defect?

 $P(defect) = \frac{1}{10} = 0.1$

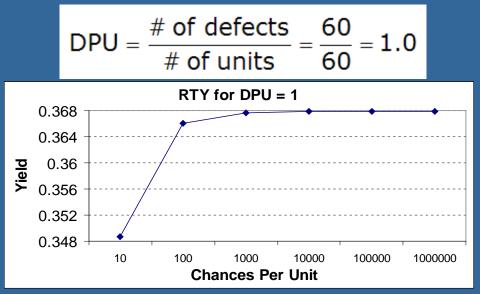
What is the probability that any given opportunity will NOT be a defect is:

$$P(\text{no defect}) = \frac{9}{10} = 0.9$$

The probability that all 10 opportunities on single unit will be defect-free is:

$$P(0) = 0.9^{10} = 0.3486$$

Basic Question: What is the likelihood of producing a unit with zero defects?



Opportunities	P(defect)	P(no defect)	RTY (Prob defect free unit)
10	0.1	0.9	0.34867844
100	0.01	0.99	0.366032341
1000	0.001	0.999	0.367695425
10000	0.0001	0.9999	0.367861046
100000	0.00001	0.99999	0.367877602
1000000	0.000001	0.999999	0.367879257

If we extend the concept to an infinite number of opportunities, all at a DPU of 1.0, we will approach the value of 0.368.

RTY Prediction — Poisson Model

Use the binomial to estimate the probability of a discrete event (good/bad) when sampling from a relatively large population, n > 16, & p < 0.1.

When r=0, we compute the probability of finding zero defects per unit (called "rolled throughput yield").

がたい	The have	table to the right sho	ws the proportion of product which will \mathbf{Y} =	_ (dpu)	r _e –dpu r! p[r]
	9-	0 defects (r=0)	1 -	- <u> </u>	r! p[r]
	ğ –	1 defect (r=1)	When DPU=1		
	_	2 defects (r=2), etc		0	0.3679
			ave a process, with 1 defect per unit,	1	0.3679
	then we say there is a 36.79% chance of finding a unit with zero defects. There is only a 1.53% chance of finding a unit with 4			2	0.1839
	defe		1.00 % chance of finding a drift with 4	3	0.0613
1	Whe	en r=1, this equation	simplifies to:	4	0.0153
		· •	with zero defect (i.e., RTY):	5	0.0031
	-	count the number of d	efects found	6	0.0005
	_	count the number of u	nits produced	7	0.0001
	_	compute the dpu and e	enter it in the dpu equation:	8	0.0000



The DPU for a given operation can be calculated by dividing the number of defects found in the operation by the number of units entering the operational step.

100 parts built 2 defects identified and corrected dpu = 0.02 So RTY for this step would be e-.02 (.980199) or 98.02%.

 RTY₁=0.98
 RTY₂=0.98
 RTY₃=0.98
 RTY₄=0.98
 RTY₅=0.98
 RTY₅=0.98
 RTY_{10T}=0.904

 DPU = .02
 DPU

If the process had only 5 process steps with the same yield the process RTY would be: 0.98 * 0.98 * 0.98 * 0.98 * 0.98 = 0.903921 or 90.39%. Since our metric of primary concern is the COPQ of this process, we can say that in less than 9% of the time we will be spending dollars in excess of the pre-determined standard or value added amount to which this process is entitled.

Note: RTY's must be multiplied across a process, dpu's are added across a process.

Focusing our Effort – FTY vs. RTY

Assume we are creating two products in our organization that use similar processes.



Product A FTY = 80% Product B

FTY = 80%



How do you know what to work on?

Focusing our Effort – FTY vs. RTY

Let's look at the DPU of each product assuming equal opportunities and margin...



Product B Product A DPU 100 / 100 = 1 DPU DPU 200 / 100 = 2 DPU Now, can you tell which to work on?



"the product with the highest DPU?" ...think again!

How much more time and/or raw material are required?How much extra floor space do we need?How much extra staff or hours required to perform the rework?How many extra shipments are we paying for from our suppliers?How much testing have we built in to capture our defects?

Selection and Design of Control Charts

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Visualizing the Data

Two Types of Data

- Attribute Data: noting the presence or absence of some characteristic or attribute in each of the units in the group under consideration:
 - Either **classifying** how many units do (or do not) possess the quality attribute,
 - or **counting** how many such events occur in the unit, group, or area.

• Continuous Data (sometimes called variables data): measuring and recording the numerical magnitude of a quality characteristic for each of the units in the group under consideration.

SPC Selection Process

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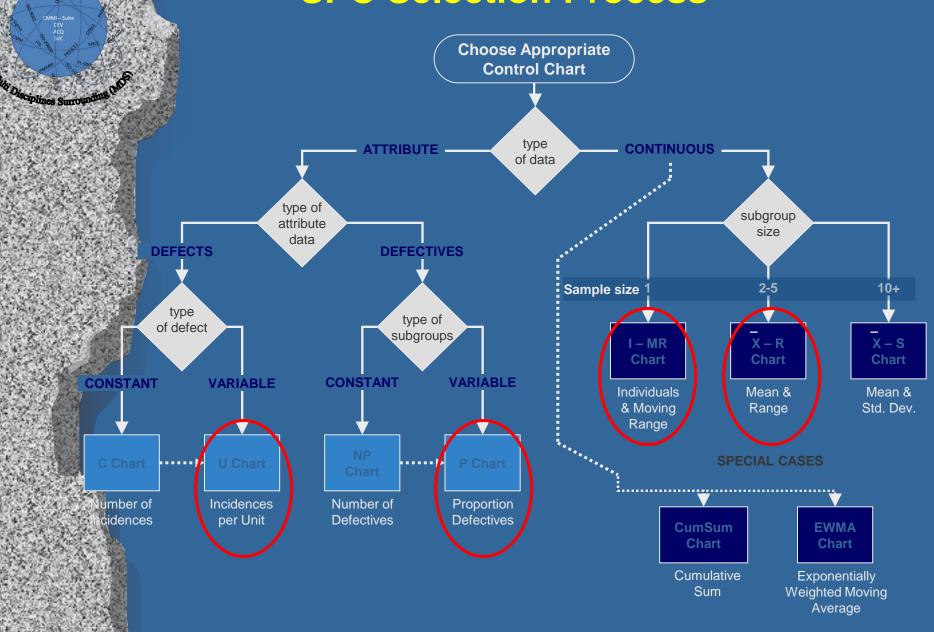
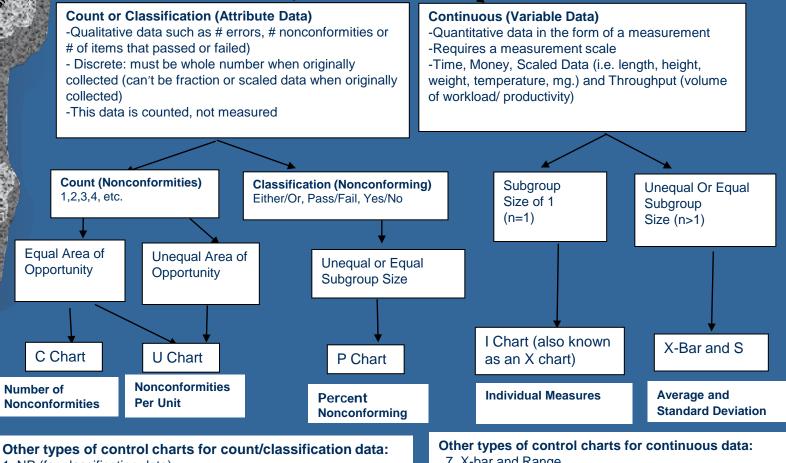


Chart Selection

Type of Data



1. NP (for classification data)

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- 2. T-chart [time (or event, items, etc.) between rare events]
- 3. Cumulative sum (CUSUM)
- 4. Exponentially weighted moving average (EWMA)
- 5. Geometric distribution chart (G chart for count data)
- 6. Standardized control chart

- 7. X-bar and Range
- 8. Moving average
- 9. Median and range
- 10. Cumulative sum (CUSUM)
- 11. Exponentially weighted moving average (EWMA)
- 12. Standardized control chart

CMM-Sute EV ACQ SVC	The choice of a control chart depends		
B Disciplines Surrounding	on the question you are trying to answer and the type of data collected		
	Type of Chart	Process: Medication Production Analysis	
	bar & R Chart	What is the Turn around time (TAT) for a daily sample of 4 product assembly orders?	
	bar & S Chart	What is the TAT for a all the engineering work orders filled each day?	
	ndividuals Chart (X or I)	How many engineering work orders do we process each week?	
	C-Chart	Using a sample of 100 engineering work orders each week, how many errors (defects) are observed?	
	U-Chart	Out of all engineering work orders each week, how many errors (defects) are observed?	
	P-Chart	For all engineering work orders each week, what percentage are not filled correctly (1 or more mistakes)?	

12 Consulting

Understanding Variable Control Chart Selection

Type of Chart

When do you need it?

Average & Range	
or S	
(Xbar and R or	
Xbar and S)	

Most common

Individual and Moving Range Production is higher volume; allows process mean and variability to be viewed and assessed together; more sampling than with Individuals chart (I) and Moving Range charts (MR) but when subgroups are desired. Outliers can cause issues with Range (R) charts so Standard Deviation charts (S) used instead if concerned.

Production is low volume or cycle time to build product is long or homogeneous sample represents entire product (batch etc.); sampling and testing is costly so subgroups are not desired. Control limits are wider than Xbar charts. Used for SPC on most inputs.

Pre-Control

Set-up is critical, or cost of setup scrap is high. Use for outputs

Exponentially Weighted Moving Average Small shift needs to be detected, often because of autocorrelation of the output results. Used only for individuals or averages of Outputs. Infrequently used because of calculation complexity.

Cumulative Sum

Less Common

Same reasons as EWMA (Exponentially Weighted Moving Range) except the past data is as important as present data.

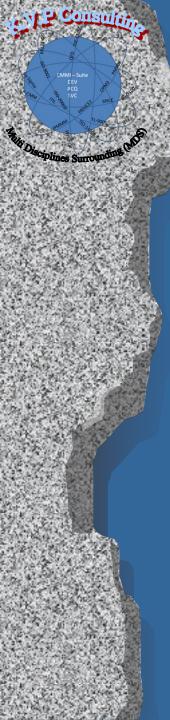
Understanding Attribute Control Chart Selection

Type of Chart

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When do you need it?

Р	 Need to track the fraction of defective units; sample size is variable and usually > 50
nP	 When you want to track the number of defective units per subgroup; sample size is usually constant and usually > 50
С	 When you want to track the number of defects per subgroup of units produced; sample size is constant
U	 When you want to track the number of defects per unit; sample size is variable



Detection of Assignable Causes or Patterns

Control charts indicate special causes being either assignable causes or patterns.

The following rules are applicable for both variable and attribute data to detect special causes.

These four rules are the only applicable tests for Range (R), Moving Range (MR), or Standard Deviation (S) charts.

- 1point more than 3 standard deviations from the center line.
- 6 points in a row all either increasing or all decreasing.
- 14 points in a row alternating up and down.
- 9 points in a row on the same side of the center line.

Detection of Assignable Causes or Patterns

These remaining four rules are only for variable data to detect special causes.

- 2 out of 3 points greater than 2 standard deviations from the center line on the same side.
- 4 out of 5 points greater than 1 standard deviation from the center line on the same side.
- 15 points in a row all within 1standard deviation of either side of the center line.
- 8 points in a row all greater than 1standard deviation of either side of the center line.

Recommended Special Cause Detection Rules

If implementing SPC manually without software initially, the most visually obvious violations are more easily detected. SPC on manually filled charts are common place for initial use of defect prevention techniques.

These 3 rules are **visually** the most easily detected by personnel.

- 1point more than 3 standard deviations from the center line.
- 6 points in a row all either increasing or all decreasing.
- 15 points in a row all within 1standard deviation of either side of the center line.

Recommended Special Cause Detection Rules

Dr. Shewhart that worked with the Western Electric Co. was credited with the following 4 rules referred to as Western Electric Rules.

- 1point more than 3 standard deviations from the center line.
- <u>8</u> points in a row on the same side of the center line.
- 2 out of 3 points greater than 2 standard deviations from the center line on the same side.
- 4 out of 5 points greater than 1 standard deviation from the center line on the same side.

You might notice the Western Electric rules vary slightly. The importance is to be consistent in your organization and decide what rules you will use to detect special causes.

VERY few organizations use all 8 rules for detecting special causes.

Calculate the parameters of the Individual and MR control charts with the following:

$\frac{\text{Centerline}}{\sum_{i=1}^{k} R_{i}} = \frac{\sum_{i=1}^{k} R_{i}}{\sum_{i=1}^{k} R_{i}}$

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here:

Control Limits

- $UCL_{x} = \overline{X} + E_{2}\overline{MR} \qquad UCL_{MR} = D_{4}\overline{MR}$ $LCL_{x} = \overline{X} E_{2}\overline{MR} \qquad LCL_{MR} = D_{3}\overline{MR}$
- Average of the individuals, becomes the centerline on the Individuals chart
 Individual data points
- k: Number of individual data points
- R_i: Moving range between individuals, generally calculated using the difference between each successive pair of readings
- MRbar: The average moving range, the centerline on the range chart
- UCL_x: Upper control limit on individuals chart
- CL_x: Lower control limit on individuals chart
- CL_{MR}: Upper control limit on moving range
- **GL_{MR} :** Lower control limit on moving range (does not apply for sample sizes below 7)
- **D**₃, D₄: Constants that vary according to the sample size used in obtaining the moving range

 $\hat{\sigma}$ (st. dev. Estimate) $\frac{MR_{bar}}{d2}$ (computed above) (table of constants for subgroup)

Calculate the parameters of the Xbar and R control c harts with the following:

Centerline

 $\sum \overline{\mathbf{x}}_{i}$

here:

Xi:

k:

Control Limits

- $UCL_{\overline{x}} = \overline{\overline{X}} + A_{2}\overline{R} \qquad UCL_{R} = D_{4}\overline{R}$ $LCL_{\overline{x}} = \overline{\overline{X}} A_{2}\overline{R} \qquad LCL_{R} = D_{3}\overline{R}$
- Average of the subgroup averages, it becomes the centerline of the control cha Average of each subgroup
- Number of subgroups
- **R**_i: Range of each subgroup (Maximum observation Minimum observation)
- **R**bar: The average range of the subgroups, the centerline on the range chart
- UCL_x: Upper control limit on average chart

 $\overline{\mathbf{R}} = \underline{\sum_{i} \mathbf{R}_{i}}$

- **LCL_x:** Lower control limit on average chart
- **UCL_R:** Upper control limit on range chart
- LCL_R: Lower control limit range chart

 A_2 , D_3 , D_4 : Constants that vary according to the subgroup sample size

 $\hat{\sigma}$ (st. dev. Estimate) $\frac{R_{bar}}{d2} = \frac{(computed above)}{(table of constants for subgrouted above)}$

Calculate the parameters of the Xbar and S control charts with the following:

Centerline

$$\overline{\overline{X}} = \frac{\sum_{i=1}^{k} \overline{x}_{i}}{k} \quad \overline{S} = \frac{\sum_{i=1}^{k} s_{i}}{k}$$

Control Limits

$$UCL_{\overline{x}} = \overline{\overline{X}} + A_{3}\overline{S} \qquad UCL_{S} = B_{4}\overline{S}$$
$$LCL_{\overline{x}} = \overline{\overline{X}} - A_{3}\overline{S} \qquad LCL_{S} = B_{3}\overline{S}$$

Where:

- X_i: Average of the subgroup averages, it becomes the centerline of the control chart
- Xi: Average of each subgroup

- **s**_i: Standard deviation of each subgroup
- **S**bar: The average s.d. of the subgroups, the centerline on the S chart
- UCL_x: Upper control limit on average chart
- LCL_x: Lower control limit on average chart
- UCL_s: Upper control limit on S chart
- LCL_s: Lower control limit S chart

A₃, B₃, B₄: Constants that vary according to the subgroup sample size

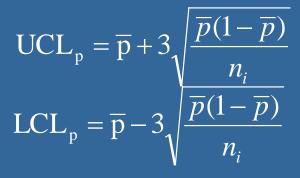
 $\hat{\sigma}$ (st. dev. Estimate) $\frac{\text{Sbar}}{c4} = \frac{(\text{computed above})}{(\text{table of constants for subgroup})}$

Calculate the parameters of the P control charts with the following:

Centerline

Total number of defective items Total number of items inspected

Control Limits



Where:

Average proportion defective $(0.0 - 1.0)$
Number inspected in each subgroup
Lower control limit on p chart
Upper control limit on p chart

Since the Control Limits are a function of sample size, they will vary for each sample

SPC Center Line and Control Limit Calculations Calculate the parameters of the **nP** control charts with the following:

Centerline

Where:

Total number of defective items Total number of subgroups

Control Limits

 $\text{UCL}_{\text{np}} = \overline{n}_{\text{i}}\overline{p} + 3\sqrt{n_{i}p(1-p)}$

$$LCL_{np} = \overline{n}_{i}\overline{p} - 3\sqrt{n_{i}p(1-p)}$$

np:	Average number defective items per subgroup
ni:	Number inspected in each subgroup
LCL _{np} :	Lower control limit on nP chart
UCL _{np} :	Upper control limit on nP chart

Since the control limits AND center line are a function of sample size, they will vary for each sample

Calculate the parameters of the U control charts with the following:

Centerline

Total number of defects IdentifiedTotal number of Units Inspected

Control Limits

$$UCL_{u} = \overline{u} + 3\sqrt{\frac{\overline{u}}{n_{i}}}$$
$$LCL_{u} = \overline{u} - 3\sqrt{\frac{\overline{u}}{n_{i}}}$$

Where:

_u: ni: LCL_u: UCL_u:

Total number of defects divided by the total number of units inspected. Number inspected in each subgroup

Lu: Lower control limit on u chart.

L_u: Upper control limit on u chart.

Since the control limits are a function of sample size, they will vary for each sample

SPC Center Line and Control Limit Calculations Calculate the parameters of the C control charts with the following:

Centerline

 $\overline{z} = \frac{\text{Total number of defects}}{\text{Total number of subgroups}}$

Control Limits

 $|\text{UCL}_{c} = \overline{c} + 3\sqrt{\overline{c}}|$

 $LCL_{c} = \overline{c} - 3\sqrt{\overline{c}}$

<u>Where</u>:



Total number of defects divided by the total number of subgroups.Lower control limit on c chart.Upper control limit on c chart.

Calculate the parameters of the Exponentially Weighted Moving Average (EWMA) control charts with the following:

Centerline

 $\sum \lambda X_{t} + (1 - \lambda) Z_{t-1}$

Control Limits

$$[CL = \overline{X} + 3\frac{\sigma}{\sqrt{n}}\sqrt{(\frac{\lambda}{2-\lambda})[1-(1-\lambda)^{2t}]}]$$

$$LCL = \overline{X} - 3\frac{\sigma}{\sqrt{n}}\sqrt{(\frac{\lambda}{2-\lambda})[1-(1-\lambda)^{2t}]}$$

Where:

Z_t:

Z_{t-1}:

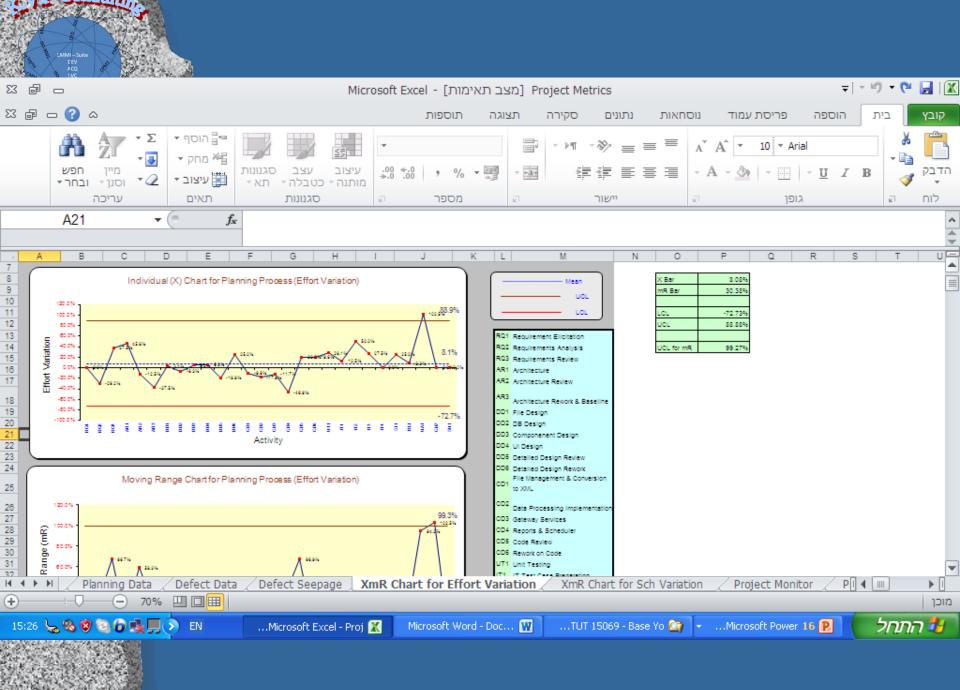
λ:

σ:

Xt:

LCL:

- EWMA statistic plotted on control chart at time t
- EWMA statistic plotted on control chart at time t-1
 - The weighting factor between 0 and 1 suggest using 0.2
 - Standard deviation of historical data (pooled standard deviation for subgroups
 - MRbar/d2 for individual observations)
 - Individual data point or sample averages at time t
- **UCL:** Upper control limit on EWMA chart
 - Lower control limit on EWMA chart
 - Subgroup sample size



UNDERSTANDING VARIATION

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Sources of Variation

Variation exists in all processes.

Variation can be categorized as either:

- <u>Common or Random causes</u> of variation, or
 - Random causes that we cannot identify
 - Unavoidable, e.g. slight differences in process variables like diameter, weight, service time, temperature
- Assignable causes of variation
 - Causes can be identified and eliminated: poor employee training, worn tool, machine needing repair

Process Capability

Product Specifications

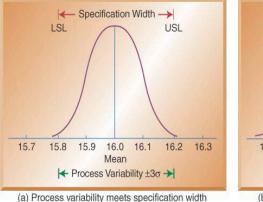
- Preset product or service dimensions, tolerances: bottle fill might be 16 oz. ±.2 oz. (15.8oz.-16.2oz.)
- Based on how product is to be used or what the customer expects

Process Capability – Cp and Cpk

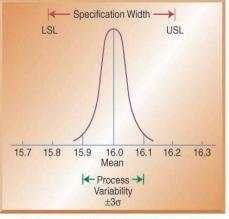
- Assessing capability involves evaluating process variability relative to preset product or service specifications
- Cp assumes that the process is centered in the specification range

 $Cp = \frac{\text{specification width}}{\text{process width}} = \frac{USL - LSL}{6\sigma}$ • Cpk helps to address a possible lack of centering of the process $Cpk = \min\left(\frac{USL - \mu}{3\sigma}, \frac{\mu - LSL}{3\sigma}\right)$

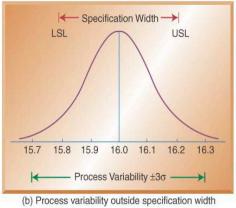
Relationship between Process Variability and Specification Width



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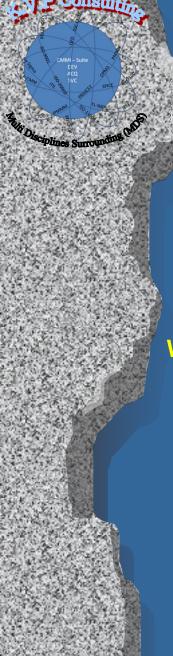




Three possible ranges for Cp

- **Cp** = 1, as in Fig. (a), process variability just meets specifications
- Cp ≤ 1, as in Fig. (b), process not capable of producing within specifications
- Cp ≥ 1, as in Fig. (c), process exceeds minimal specifications
- One shortcoming, Cp assumes that the process is centered on the specification range
- **Cp=Cpk** when process is centered

Measures of Variation include: The range The Variance •The Standard Deviation The standard deviation is just the square root of the variance •The Mean Absolute Deviation



Standard Deviation of a Population

We will label the population variance to be σ^2

And define $\sigma^2 = \sum_i (x_i - \mu)^2 / N$

Where

μ is the population mean N is the size of the population

 $\sum_{i} (x_i - \mu)^2$ is the sum of the squares of the difference between each item in the population and the mean.



Suppose a student receives the following quiz grades:

{82, 68, 74, 86, 90, 88, 62, 75, 80, 55}

For this student, these grades are the total population of her scores that are used to calculate her mean or average grade. We obtain:

 $\mu = (82 + 68 + 74 + 86 + 90 + 88 + 62 + 75 + 80 + 55)/10$ = 760/10 = 76

The mean of this population is 76



 $\{82, 68, 74, 86, 90, 88, 62, 75, 80, 55\}$ and $\mu = 76$

 $\sigma^2 = \sum_i (x_i - \mu)^2 / N$

 $= \{(82-76)^2 + (68-76)^2 + (74-76)^2 + (86-76)^2 + (90-76)^2 + ($

 $(88-76)^{2} + (62-76)^{2} + (75-76)^{2} + (80-76)^{2} + (55-76)^{2} / 10$

= (36 + 64 + 4 + 100 + 196 + 144 + 196 + 1 + 16 + 441)/10

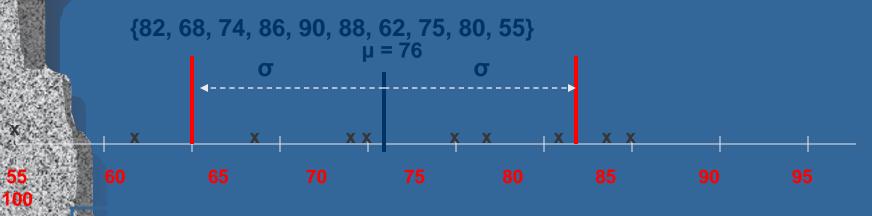
= 119.8

We find the standard deviation in this population data by taking the square root of the variance.

$$\sigma^2 = \sum_{i} (x_i - \mu)^2 / N = 119.8$$

 $\sigma = (119.8)^{\frac{1}{2}} = 10.94$

If we display the data on a dot plot, we can visualize the use of the standard deviation as a measure of variation in the data



Mean = 76

Chebyshev's Theorem

The proportion of <u>any</u> set of data lying within K standard deviations of the mean is always *at least* $1 - 1/K^2$, for all K greater than or equal to 2.

Chebyshev's Inequality tells us that in any statistical distribution at least ³/₄ of the values will lie within 2 standard deviations of the mean, and at least 8/9 of all values will lie within 3 standard deviations of the mean.

In the previous example we found μ = 76 and σ = 10.94

 μ - 2 σ = 76 - 2(10.94) = 54.12

 $\mu + 2\sigma = 76 + 2(10.94) = 97.88$

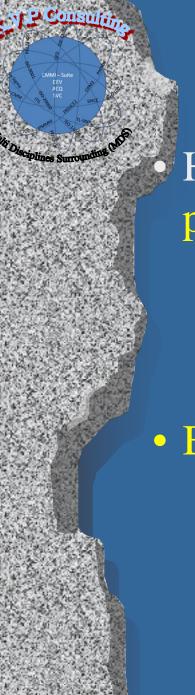
We find that 100% of the values lie within 2σ of the mean

CASE STUDY – FIRST PHASE

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REDUCING VARIATION

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Selecting improvements to implement

High-level objective evaluation of all potential improvements

- Impact of each improvement
- Cost to implement each improvement
- Time to implement each improvement
- Balance desire with quantifiable evaluation
 - Engineering always wants the gold standard
 - Sales always wants inventory
 - Production always wants more capacity

Impact of the improvement

^{*}Time frame of improvements

- Long-term vs. Short-term effectiveness
 - If a supplier will lose a major customer because of defects, the short term benefit will prevail first.

Effectiveness of the improvement types

- Removing the root cause of the defect
- Monitoring/flagging for the condition that produces a defect
- Inspecting to determine if the defect occurred
- Training people not to produce defects

Cost to implement improvement

Initial cost to implement improvement

- Cost to train existing work force
- Cost to purchase any new materials necessary for improvement
- Cost of resources used to build improvement
- Any capital investments required
- On-going costs to sustain improvement
 - Future training, inspection, monitoring, and material costs

Time to implement improvement:

Technical time constraints

- What is the minimum time it would take to implement?
 - Time to build/create improvement, time to implement improvement

Political time constraints

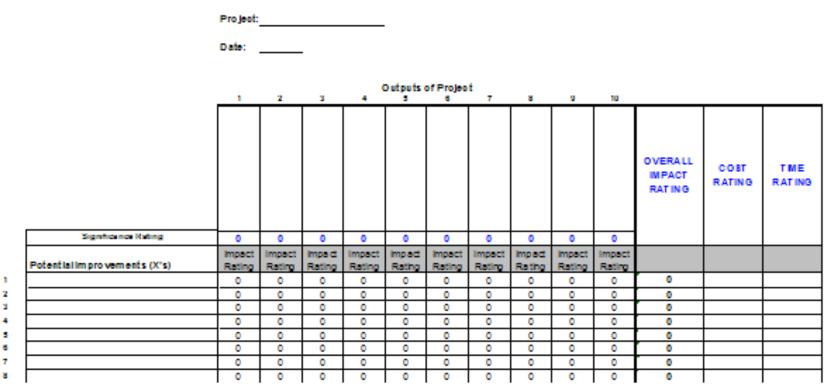
- What other priorities are competing for the technical time to build the improvement?
- Cultural time constraints
 - How long will it take to gain support from necessary stakeholders?

The clock's ticking.....





IMPROVEMENT MATRIX



Solution Matrix.xls

Impact Ratings

X's are removed from impacting the process output. 7 Continual control and adjustment of critical X's impacting the 6 process output. Continual control of critical X's prevents defects in the process 5 output from X. Defect detection of the process output prevents unknown defects 4 from leaving the process. Process inspection or testing is improved to find defects better. 3 Process is improved with easier control of a critical X impacting the 2 process output. Personnel are trained about X's impact on the process output. 1 X's have no impact on the process output. \mathbf{O}

Cost to Implement Ratings

- 7 Improvement Costs are minimal with upfront and ongoing expenses.
- 6 Improvement Costs are low and can be expensed with no capital authorization and recurring expenses are low.
- 5 Improvement Costs are low and can be expensed with no capital authorization and recurring expenses are higher.
- 4 Medium capital priority because of relative ranking of return on investment.
- 3 Low capital priority because of relative ranking of return on investment.
- 2 High capital and ongoing expenses make a low priority for capital investment.
- High capital and/or expenses without acceptable return on investment.

 $\mathbf{0}$

Significant capital and ongoing expenses without alignment with business priorities.

Time to Implement Ratings

- Less than a week to get in place and workable.
- 6 7 14 days to get in place and workable.

2

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- 5 2 8 weeks to get the improvement in place and workable.
- 4 2 3 months to get the improvement in place and workable.
- 3 3 6 months to get the improvement in place and workable.
 - 6 9 months to get the improvement in place and workable.
 - 9 12 months to get the improvement in place and workable.

Over a year to get the improvement in place and workable. All above times include time for approvals process.

Example of Completed Solution Selection Matrix

Significance Rating	Dutside noises do not interfer with speakers	د Coffee is hot and rich tasting	$^{\infty}$ Plenty of bottled water available	ه Food choices include "healthy choices"	OVERALL IMPACT RATING	COST RATING	TIME RATING	OVERALL RATING
Potential Improvements	Impact Rating	Impact Rating	Impact Rating	Impact Rating				
Hotel staff monitors room	2	2	6	0	86	7	7	4214
Mgmt visits/leaves ph #	2	0	4	0	52	7	7	2548
Replace old coffee makers/coffee	0	7	0	0	63	3	6	1134
Menus provided with nutrition info	0	0	0	4	36	5	5	900
Comp. gen. "quiet time" scheduled	6	0	0	0	60 63	3 5	3	540 630

Improvement Selection Matrix Output

Improvements with the higher overall rating should be given first priority.

Keep in mind that long time frame capital investments, etc. should have parallel efforts to keep delays from further occurring.

plementing Solutions in Your Organization

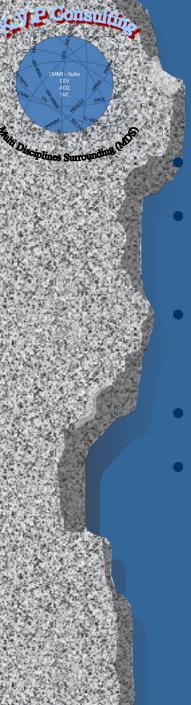
Implementation plans should emphasize the need to:

- Organize the tasks and resources
- Establish realistic time frames and deadlines
- Identify actions necessary to ensure success

Components of an implementation plan include:

- Work breakdown structure
- Influence strategy for priorities and resourcing
- Risk management plan
- Audit results for completion and risks.

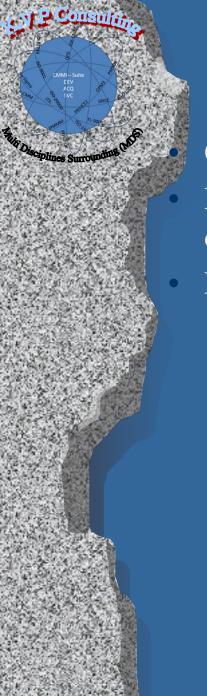
All solutions must be part of Control Plan Document.



What is a Control Plan?

Written summary describing systems used for monitoring/controlling process or product variation

- Document allowing team to formally document all control
- methods used to meet project goal
- Living document to be updated as new measurement systems and control methods are added for continuous improvement



What is a Control Plan?

Often used to create concise operator inspection sheet NOT a replacement of information contained in detailed operating, maintenance, or design instructions ESSENTIAL portion of final project report

- Final projects are organizationally dependent
 - Informal or formal
- Filed as part of project tracking mechanism for organization
 - Track benefits
 - Reference for unsustained results

WHO Should Create a Control Plan

The team working on the project!!!!

ANYONE who has a role in defining, executing or changing the process:

- Associates
- Technical Experts
- Supervisors
- Managers
- Site Manager
- Human Resources

Why Do We Need a Control Plan?

Project results need to be sustained.

- Control Plan requires operators/engineers, managers, etc. to follow designated control methods to guarantee product quality throughout system
- Allows to move onto other projects!

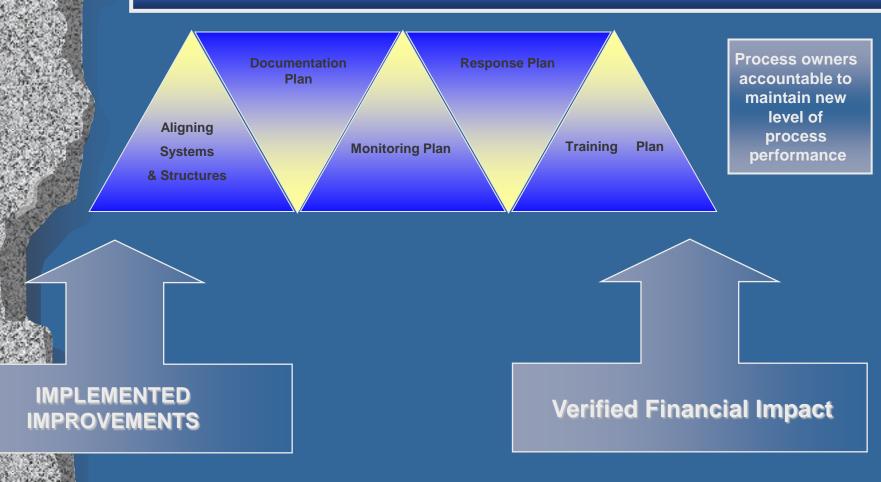
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- Prevents need for constant heroes in an organization who repeatedly solve the same problems
- Control Plans are becoming more of a customer requirement

Control Plan Elements

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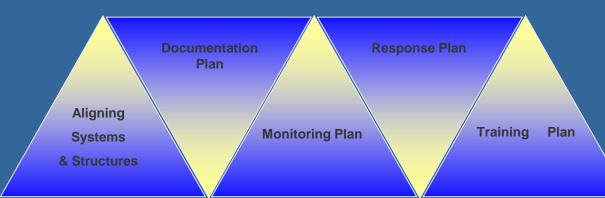
Control Plan



Control Plan Information

The team develops the Control Plan by utilizing all available information from the following:

- Results from the Measure, Analyze and Improve Phases
- Lessons learned from similar products and processes
- Team's knowledge of the process
- Design FMEAs
- Design reviews
- Defect Prevention Methods selected



Training Plan



Who/What organizations require training?

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- Those impacted by the improvements
 - People who are involved in the process impacted by the improvement
 - People who support the process impacted by the improvement

• Those impacted by the Control Plan

- Process owners/managers
- People who support the processes involved in the Control Plan
- People who will make changes to the process in the future

Training Plan

No will complete the training?

• Immediate training

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• The planning, development and execution is a responsibility of the project team

Training Plan

- Typically some of the training is conducted by the project team
- Qualified trainers
 - Typically owned by a training department or process owner
 - Those who are responsible for conducting the on-going training must be identified

Specific training materials need developing.

• PowerPoint, On the Job checklist, Exercises, etc.



Training Plan



What is the timeline to train everyone on the new process(es)?

What will trigger ongoing training?

- New employee orientation?
- Refresher training?
- Part of the response plan when monitoring shows performance degrading?

Documentation Plan

Documentation is necessary to ensure that what has been learned from the project is shared and institutionalized:

Plan

- Used to aid implementation of solutions
- Used for on-going training

This is often the actual Final Report some organizations use.

Documentation must be kept current to be useful

Documentation Plan

Documentation Plan

Tems to be included in the documentation plan:

Process documentation

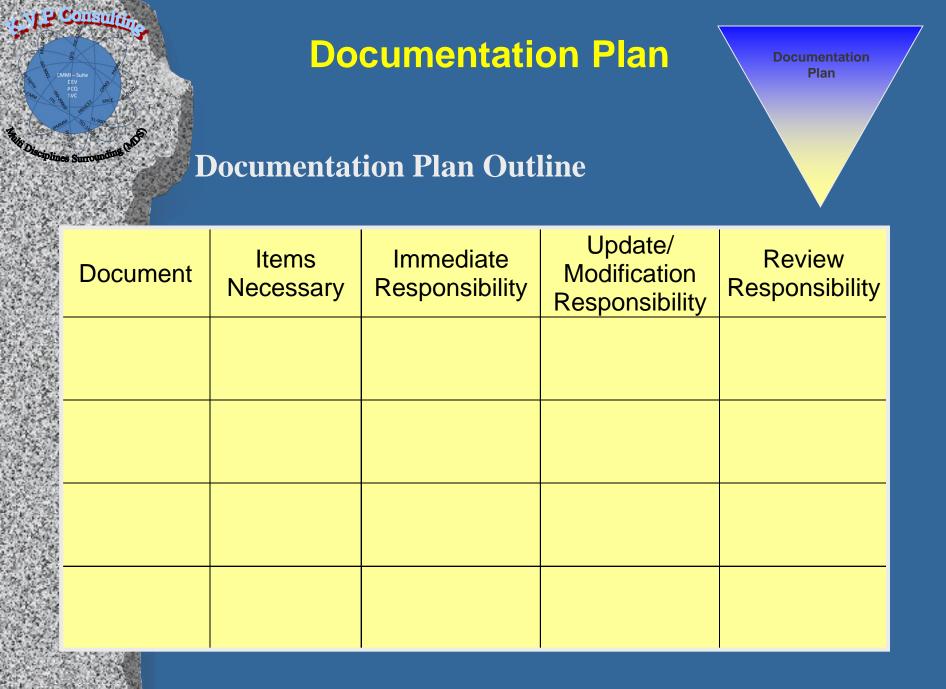
- Updated Process maps/flowcharts
- Procedures (SOP's)
- FMEA
- Control Plan documentation
 - Training manuals
 - Monitoring plan—process management charts, reports, sops
 - Response plan—FMEA
 - Systems and structures—job descriptions, performance management objectives

Documentation Plan

Documentation Plan

signing responsibility for documentation plan:

- Responsibility at implementation
 - Black belt ensures all documents are current at hand off
 - Black belt ensures there is a process to modify documentation as the process changes in place
 - Black belt ensures there is a process in place to review documentation on regular basis for currency/accuracy
- Responsibility for ongoing process (organizationally based)
 - Plan must outline who is responsible for making updates/modifications to documentation as they occur
 - Plan must outline who is responsible to review documents ensuring currency/accuracy of documentation





Purpose of a monitoring plan:

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- Assures gains are achieved and sustained
- Provides insight for future process improvement activities

Development of a monitoring plan:

- Belt is responsible for the development of the monitoring plan
- Team members will help to develop the plan
- Stakeholders must be consulted
- Organizations with financial tracking would monitor results.



Sustaining the monitoring plan:

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- Functional managers will be responsible for adherence to the monitoring plan
 - They must be trained on how to do this
 - They must be made accountable for adherence



• When to Sample

Fests:

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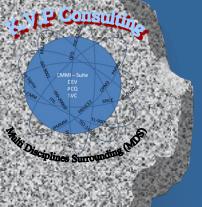
- After training
- Regular intervals
- Random intervals (often in auditing sense)
- How to Sample
- How to Measure

Statistical process control:

- Control charts
 - Posted in area where data collected

Monitoring Plan

- Plot data points real time
 - Act on Out of Control Response with guidelines from the Out of Control Action Plan (OCAP).
 - Record actions taken to achieve in-control results.
- Notes impacting performance on chart should be encouraged
- Establishing new limits
 - Based on signals that process performance has changed



Response Plan



FMEA is a great tool to use for the monitoring plan

#	Process Function (Step)	Potential Failure Modes (process defects)	Potential Failure Effects (Y's)	S E V	C I a s	Potential Causes of Failure (Xs)	0 0 0 0	Current Process Controls	D E T	R P N	Recommend Actions	Responsible Person & Target Date	Taken Actions	S E V	0 C C	D E T	R P N
1																	
2																	
3																	
4																	
5																	
6																	

• Allows process manager and those involved in the process to see the entire process and how everyone contributes to a defect free product/service.

Provides the means to keep the document current—reassessing RPNs as the process changes



Check Lists/Matrices

- Key items to check
- Decision criteria; decision road map
- Multi-variable tables

Visual Management

- Alerts or signals to trigger action.
 - Empty bins being returned to when need stock replenished
 - Red/yellow/green reports to signal process performance
- Can be audible also.

Response Plan

Response Plan

Response plans—outline process(es) to follow when here is a defect or Out of Control from monitoring:

- Out of control point on control chart
- Non random behavior within control limits in control chart
- Condition/variable proven to produce defects present in process
- Check sheet failure
- Automation failure

Response to poor process results are a must in training.

Response plans are living documents updated with new information as it becomes available

Response Plan

Response Plan

components of response plan:

- The triggers for a response
 - What are the failure modes to check for?
 - Usually monitor the highest risk x's in the process
- The recommended response for the failure mode
- The responsibilities for responding to the failure mode
- Documentation of response plan being followed in a failure mode
- Detailed information on the conditions surrounding the failure mode

Response Plan – Abnormality Report

Response Plan

- Detailed documentation when failure modes
 - occur.
- Provide a method for on-going continuous improvement.
- Reinforce commitment to eliminating defects.
- Fits with ISO 9000 standard of having a CAR or Corrective Action Request.
- Method to collect frequency of corrective actions.

	Process				
ation	Metric				
Current Situation	Signal				
Curre	Situation C				
	Detailed Si	ituation			
<mark>Cause</mark>	Date				
Investigation of Cause	Code of Ca	ause			
Investi	Corrective .	Action			
cis	Who To Be	e Involved			
<mark>e Analys</mark>	What To B	e Done			
Root Cause Analysis		ompletion of			
Rc	Date for im				

Aligning Systems and Structures

Systems and structures are the basis for allowing people to change their behaviors permanently:

Aligning

Systems & Structures

- Performance goals/objectives
- Policies/procedures
- Job descriptions
- Incentive compensation
- Incentive programs, contests, etc

There are long- and short-term strategies for alignment of systems and structures

Aligning Systems and Structures

Get rid of measurements that do not align with desired behaviors



• Get rid of multiple measures for the same desired behaviors

Implement measures that align with desired behaviors currently not motivated by incentives

Change management must consider your process changes and how the process will respond?

Are the hourly incentives hurting your chance of success?

Project Sign Off

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Best method to assure acceptance of Control Plan is having supervisors and management for the area involved.

- Meeting for a summary report
- Specific changes to the process highlighted
- Information where Control Plan is filed

CASE STUDY – SECOND PHASE

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Why to Monitor Processes

'Cheshire Puss,' she began, ... `Would you tell me, please, which way I ought to go from here?' 'That depends a good deal on where you want to get to,' said the Cat.

'I don't much care where –' said Alice. 'Then it doesn't matter which way you go,' said the Cat. '- so long as I get *somewhere*,' Alice added as an explanation. 'Oh, you're sure to do that,' said the Cat, 'if you only walk long enough.'



Tell me where you want to be and I will show (measure) you the way

HOLING SVC	Center	
lines S		0%
	max	100%
	ave	50%
	sample Projects	104
	% From ORG	100.00%
	Sample Practices	19629
	% From Sample	100.00%
	is 0	2649
	% of is 0	13.50%
	>4	9147
	% of >4	46.60%
	<4	7828
	<u></u> <u>% of <4</u>	39.88%
	is 4	2654
	% of is 4	13.52%
÷.	>6	4818
	% of <u>></u> 6	24.55%
	mean	#NUM!
1	median	4
	mode	8
	VAR	7.279
1.04		

Areas

Const

	A1	A2	A3	A4	A5	A6	A7
<mark>∞</mark> min	0%	0%	0%	0%	0%	0%	0%
max	100%	100%	100%	100%	100%	100%	100%
ave	50%	50%	37.5%	62.5%	50%	50%	75%
sample Projects	22	6	3	13	23	13	24
% From ORG	21.15%	5.77%	2.88%	12.50%	22.12%	12.50%	23.08%
Sample Practices	3733	957	647	2069	4961	2914	4348
% From Sample	19.02%	4.88%	3.30%	10.54%	25.27%	14.85%	22.15%
<mark>is 0</mark>	526	127	154	195	914	378	355
<mark>% of is 0</mark>	14.09%	13.27%	23.80%	9.42%	18.42%	12.97%	8.16%
>4	1575	476	213	1092	1850	1413	2528
<mark>% of >4</mark>	42.19%	49.74%	32.92%	52.78%	37.29%	48.49%	58.14%
< <u><4</u>	1626	347	322	705	2358	1165	1305
∽ <mark>% of <4</mark>	43.56%	36.26%	49.77%	34.07%	47.53%	39.98%	30.01%
<mark>is 4</mark>	532	134	112	272	753	336	515
<mark>% of is 4</mark>	14.25%	14.00%	17.31%	13.15%	15.18%	11.53%	11.84%
<mark>>6</mark>	779	211	82	579	775	733	1659
<mark>% of <u>></u>6</mark>	20.87%	22.05%	12.67%	27.98%	15.62%	25.15%	38.16%
mean 📃	#NUM!						
<mark>median</mark>	4	4	4	5	4	4	6
<mark>mode</mark>	2	6	0	6	0	6	8
VAR	7.058	6.898	6.750	6.853	6.654	7.142	7.265

Configuration Management

	min	max	ave	samp	>4	% of >4	<u><4</u>	<u>% of <4</u>	is 4	% of is 4	>6	% of <u>></u> 6	mean	median	mode	VAR
Identify Configuration Items	0%	75%	37.5%	104	12	12%	82	79%	10	10%	0	0%	#NUM!	3	3	1.97
Establish a Configuration Management System	0%	100%	37.5%	104	10	10%	81	78%	13	13%	1	1%	#NUM!	3	3	2.21
Create or Release Baselines	0%			104	8	8%	82	79%	14	13%	1	1%	#NUM!	2	2	1.94
Track Change Requests	0%	87.5%	25%	103	8	8%	88	85%	7	7%	1	1%	#NUM!	2	0	2.90
Control Configuration Items	0%	62.5%	25%	104	2	2%	94	90%	8	8%	0	0%	#NUM!	2	2	1.67
Establish Configuration Management Records	0%	62.5%	12.5%	104	1	1%	98	94%	5	5%	0	0%	#NUM!	1	0	1.69
Perform Configuration Audits	0%		12.5%		4	4%	96	92%	4	4%	1	1%	#NUM!	1	0	2.05

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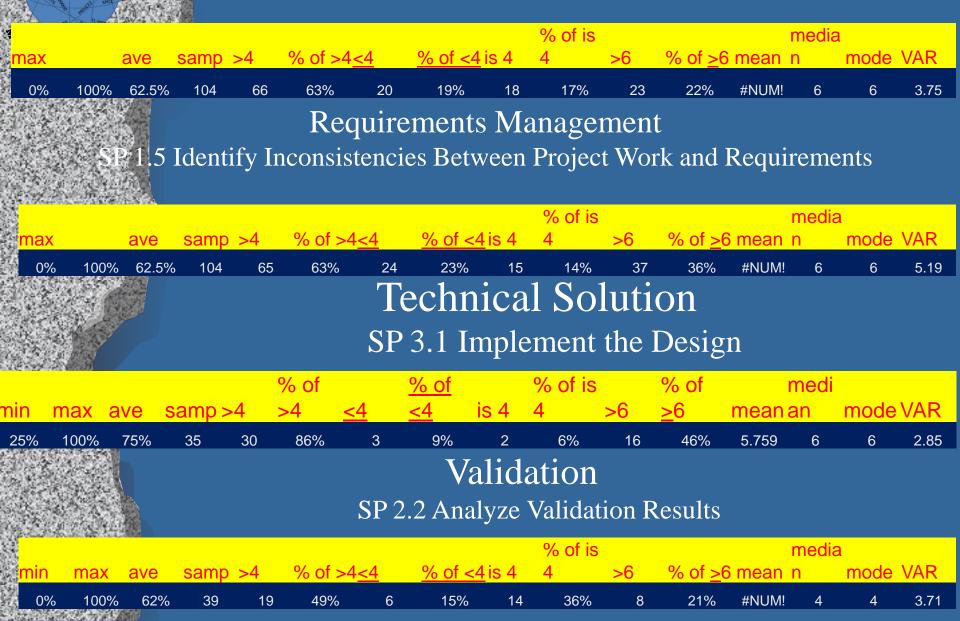
Integrated Project Management

â														medi		
13	min	max	ave	samp	>4	% of >4	<u><4</u>	<u>% of <4</u>	is 4	% of is 4	>6	% of <u>></u> 6	mean	an	mode	VAR
Establish the																
Project's Defined	.			10	•		0-	6 6 6 4		4004						o (=
Process	0%	75%	2	46	3	7%	37	80%	6	13%	0	0%	#NUM!	2	2	2.47
Use																
Organizational																
Process Assets																
for Planning	.			10		10/	10	0- 0 <i>(</i>		0 01						
Project Activities	0%	75%	2	46	2	4%	40	87%	4	9%	0	0%	#NUM!	2	0	2.38
Establish the																
Project's Work	001	4000/		10	~~	000/	_	470/	•	4.40/	10	4000				
Environment	0%	100%	6	42	29	69%	7	17%	6	14%	18	43%	#NUM!	6	8	5.37
Integrate Plans	0%	87.5%	2	46	7	15%	33	72%	6	13%	1	2%	#NUM!	2	0	3.94
Manage the																
Project Using the			-											_	-	
Integrated Plans	0%	87.5%	2	46	8	17%	36	78%	2	4%	1	2%	#NUM!	2	0	4.25
Contribute to the																
Organizational																
Process Assets	0%	50%	1	46	0	0%	42	91%	4	9%	0	0%	#NUM!	1	0	1.63
Manage																
Stakeholder	.	0--- 0(10	. —	0 0 (4004		.				4
Involvement	0%	87.5%	3	46	17	37%	23	50%	6	13%	4	9%	#NUM!	4	1	5.51
Manage	00/	07 50		10		000/	05	700/		407		00/			_	0.54
Dependencies	0%	87.5%	3	46	9	20%	35	76%	2	4%	1	2%	#NUM!	2	2	3.54
Resolve																
Coordination	00/	07 50		10	10	000/		0404	_	4.4.07		40/				0.07
Issues	0%	87.5%	3	46	13	28%	28	61%	5	11%	2	4%	#NUM!	3	2	3.87

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Requirements Management

SP 1.4 Maintain Bidirectional Traceability of Requirements



Verification SP 3.2 Analyze Verification Results

24 4									% of is			n	nedia	1	
(<mark>min</mark>	max	ave	samp	>4	% of >4	<u><4</u>	<u>% of <4</u>	is 4	4	>6	% of <u>></u> 6	mean r	1	mode	VAR
0%	100%	62.5%	39	20	51%	12	31%	7	18%	12	31%	#NUM!	5	7	5.13

Organizational Background and Process ROI

Project Idea and Proposal Preposition Development

- If an average developer day cost is ~7000
- The total Program effort was 10220 day (100%)
- The testing phase was 1480 day (14.5%)
- Defect that are the result of documentation are 69% of all defects
- If we will assume the to correct 69% of all defects will take around 40% of the testing duration;
 means that:
 - that will be 740 day
 - With the overall cost of 518000
- However to add 100 review days in the static tests and another 20 of code inspection will end with the cost of 2100000
- And still we have saved at least 3080000 (440 days)
- Means that we ware able to reduce 4.5% of the project time

Questions ?

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"which way I ought to go from here" $Call \ Center - Calls \ Database$

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1	Er Brat Prode Blater			Bala Bar had Bill had Bill	Autotte Attions At		Event on Bala and Banaras land a P las	das fores and fores and for	In To Impost & Implant	Includ Inform CE Blat	16 Boat 16, Boat 16, Blot		alada Bal. as. BIE I		IET.I.I.B	dayt Course Borrana
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10		E										Frequences		BEBER Propriet & Brook	Bogs to 3.8.9	Baalad aanaa
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- 18	13878 I-Bigen Coul 13879 3-Bil Coul	Contract Contract Contract Contract					£	E. E.I.			34187			AND Colombia 64333	Big 2.18.4 Big 2.18.4	TEI Indian
12		P									34131	Presilier		BEER Provident 64249	3.18.4	TEI sulu
18	13881 3-811 E.m.	E	· · · · · · · · · · · · · · · · · · ·	·····	teller		•	E. C.I.e.		Receive Room	34373 34118 19147 Eaul	B.I.I.		AND A	Bag 3.18.4	TEI
20	13883 I-Bayes Coul 13883 3-Bat Coul	Laladar Banda Banda Batt					:	E. E.I.			24110 14147 E.m.			AND Appel/Input ANDE 64333	Big 2.437 Big 2.18.4	TEL LINI
31	13884 I-Begen Coul	C	in Black inter		retres II			E. E.I.			34183 11838 5	CORDER Programmy		BERE Plana Mala 6430	8. 3.18.4	TEI Inline
33	13888 3-811 E	Material Control Control Control					•	E. C.I.e.		BERE Clubble Base	34313 44348 Coul 34136 13787 Coul			BARR Inclose & Bysen & 64474	Bag 3.18.4	TEI
33							:	E. E.I.e.			34136 13387 Cool				Bay 3.18.4 Bay 3.18.4	T 81
38	13888 3-Males Coul	Property 68888 68888 6000	B. 88.88					E. Colono		Annen Anne	24488	Balalas		88888 Ton 64644	8.18.4	T
36		······ · · · · · · · · · · · · · · · ·					**				34313 13189 51			CONTRACTOR CONTRACTOR CONTRACTOR	1.1 D.437	area trated
37	13848 I-Bayes Coul 13841 I-Bayes Coul						: :			1 ., 1	34148 11843 Coul	F		ANDE Induce 6 gener AMARE 64340	1.1 2.422	
34	13843 I-Bogen Coul									Eludal-a	34344 13878 Coul		1376	BEER Marter Balatan - BMBBC 64484	8.1 3.437	
38	13843 3-811 Enel 13844 3-811 Enel	1					*	E. C.I.	:	Clarke Clarkel- Can	34648 41793 Coul				Beg 3.18.4 Beg 3.18.4	TEI ender
31	13844 J-Brin Coul	Chapping and a second strain			and an East of		: :	E. Colono		Charles Charles	34634 13847 Coul			66666 Company 64667 66666 Parganan 6 Canal 6 6 6 6 6 6 6 6 6 6 6 6 6 6 6 6 6 6 6		
33	13896 3-811 E.ml				B-01 B1						34181	lagas		Erler 64278	8.1 2.427	
34	13847 I-Bigen Coul	8.1. 8 88888 88888 88E					•			Reg Real		BECONI Balalas		BARR Marter Balaine BMBBE 64381	Big 3.437	
38	13848 I-Bayes Could	Elalar I BERRE BERRE BER			Information and		:	E. E			34346	laladaan ah		AND Appeldiaged AMARE 64837	Big 3.437 Contas 3.18.4	TEL Labor
37	12188 I-Bages Coul		in Bills Inform							Eludat-s	34188 13433 EI	BECONT Informations		BERE Bagadiflagad BMBEC 64383	84 3.437	and later
38	13181 3-Miller Coul						**				34343 34319 997 Eurol	B aladay	1388	SEES Made Solder 2.4.37 64664	Bij 2.427	AND AND AND A
- 18	13183 3-Malas Cool 13183 1-Barro Cool	100-W1 0000 0000 0000					: :				34314 11447 Cool			BARA Providen Protogo 64489 BARA Bayers Color 64391	1) 2.437 1) 3.437	
41	13184 3-81 E.ml				BI					Received.		B.I.I.		BEER Marter Belefer	8. 3.13.3	Bootof annual
43	13188 3-811 Errol									Elastat-a	34399 13894 13183 Cool			10000 lapo 2.4.37 64040 10000 Augusto 13103	Big 2.437 Big 2.18.4	BBC Ball
43							:	E. C.I.e.			34188	F		Tol 2022	Bag 3.18.4 Bag 3.18.4	T
48	13188 3-8 ₁ 1 Coul							E. Colono		1	34318 13748 End			BERE Propriet & Brook Barrow & & 4488	8. 2.18.4	TEI
46	13184 I-Bayes Could						<u>.</u>			Elastat-a	34134 34386 3768 E			CONTRACTOR	01 2.437 01 2.437	
42	13111 3-811 5-01						2			Eludat-	24224	E		10000 1 000 1 0000 1 00000 1 00000 1 0000000000	Big 2.437 Big 2.437	
44	13113 3-811 5-111									Elected-m	38378	P		BBBB BILL BBB43	Barge to 3.18.4	BEL Instanti
	13113 I-Bopon Court	Manana Manan Manan Mata					•				34334 34348 3 Euri				Big 3.18.4 Big 3.437	
	13114 3-811 Errol 13118 3-Water Errol	· Italian Based Based Bata					:	E. Colono			34338 300 Cool			BEER Floor Main 64428	Big 2.427 Big 2.18.4	TEL
83	13116 I-Bayra Court				B.00 BI					Eludal-m	24284 ININE Coul	BECONT Infordation		BARR Reputriepol BARRE 64838	8.1 3.437	
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82		tet Bert Bases Bases Begg	B. BB.BB Bl., B.					E. Colomo		1	34367 41873 Enul			BARRA light billes	8.0 2.18.4	TEI
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- 61	13134 3-Millis Coul	1.1 Bart 10000 10000 1.000					•	E: Eilimii		lud Bren	24266 41871 Billio			64887 Barr	Big 3.18.4	TEI
63	13138 3-Miles Bays and 13136 3-841 - Coul	Manas 10000 00000 7). Padas 10000 0000 0000		10000 202000 10000 1000	feller .		R. Parladas Ball. R. BREE La.			Belo Contonio					Compos 3.18.4	
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28	13133 3-811 Enni 13134 1-8000 Enni		in an in the second	the second design	Hardens Califier Bi		8. P			Eludid-	24992				Configure BC Bassie	TTER Handan
23		·····			hald H		6			Eludal-a	34333			64624 Barr		area loalol
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24	13137 3-811 Ennt		na Bass Harles	Contract of the second se	Hadang II		Test (1977)			Electricity	38434 3816 Ennl 34348 3474 Ennl			10000 Data 60647	Contyre BC Bassie Contyre BC Bassie	TTER Band
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14	13147 3-811 Enul	ter the second second but the			anal B					Eludal-a	13886 13887 Coul			13887	1, 2.10.4	Boold annul
		anip in													Big 3.18.4	BBCI Instanti
117		Lond on Based Based Col 9										Bagashi Bagashi		and a second	11 3.13.3 11 3.18.3	

~45000 Records With 22 Attributes





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~33000 Records With 36 Attributes